TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7SZ86F,TC7SZ86FU

EXCLUSIVE OR Gate

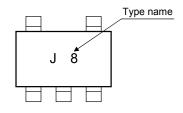
Features

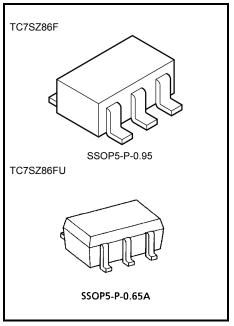
- High output drive: ±24 mA (min) at V_{CC} = 3 V
- Super high speed operation: t_{pd}=2.9 ns (typ.)

at $V_{CC} = 5 \text{ V}, 50 \text{ pF}$

- Operation voltage range: V_{CC (opr)} = 1.8~5.5 V
- 5.5-V tolerant inputs
- 5.5-V power down protection output
- Matches the performance of TC74LCX series when operated at 3.3- V V_{CC}

Marking





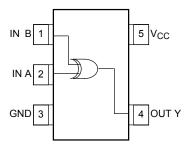
Weight

SSOP5-P-0.95 : 0.016 g (typ.) SSOP5-P-0.65A : 0.006 g (typ.)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V _{CC}	-0.5~6	V	
DC input voltage	V _{IN}	-0.5~6	V	
DC output voltage	V _{OUT}	-0.5~6	V	
Input diode current	I _{IK}	-20	mA	
Output diode current	lok	-20	mA	
DC output current	I _{OUT}	±50	mA	
DC V _{CC} /ground current	Icc	±50	mA	
Power dissipation	P _D	200	mW	
Storage temperature	T _{stg}	-65~150	°C	
Lead temperature (10s)	TL	260	°C	

Pin Assignment (top view)



Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Logic Diagram



Truth Table

Inp	out	Output
Α	В	Y
L	L	L
L	Н	Н
Н	L	Н
Н	Н	L

Operating Ranges

Characteristics	Symbol	Rating	Unit	
Supply voltage	Vcc	1.8~5.5	V	
Supply voltage	vcc vcc	1.5~5.5 (Note 1)	V	
Input voltage	V _{IN}	0~5.5	V	
Output voltage	V _{OUT}	0~5.5 (Note 2)	V	
		0~V _{CC} (Note 3)	V	
Operating temperature	T _{opr}	-40~85	°C	
		$0\sim20~(V_{CC}=1.8~V,~2.5~V\pm0.2~V)$		
Input rise and fall time	dt/dv	$0 \sim 10 \ (V_{CC} = 3.3 \ V \pm 0.3 \ V)$	ns/V	
		$0~5~(V_{CC} = 5.5~V \pm 0.5~V)$		

Note 1: Data retention only

Note 2: $V_{CC} = 0 V$

Note 3: High or Low state

Electrical Characteristics

DC Characteristics

Characteristics Symbol Test Condition			Ta = 25°C			Ta = -40~85°C		Unit		
		st Condition	V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic	
High-level input voltage VIH —			1.8	0.75 × V _{CC}	_	_	0.75 × V _{CC}	_	· V	
			2.3-5.5		0.7 × V _C C	_	_	0.7 × V _{CC}		_
Low-level input	V	V _{IL} _			_		0.25 × V _{CC}	_	0.25 × V _{CC}	V
voltage	۷IL		_	2.3-5.5			0.3 × V _{CC}		0.3 × V _{CC}	V
				1.8	1.7	1.8	_	1.7	_	
			I _{OH} = -100 μA	2.3	2.2	2.3		2.2	—	
			10Η = -100 μΑ	3.0	2.9	3.0		2.9	_	
High-level	Voh	$V_{IN} = V_{IH}$		4.5	4.4	4.5	_	4.4	_	V
output voltage	VOH	or V _{IL}	$I_{OH} = -8 \text{ mA}$	2.3	1.9	2.15	_	1.9	_	- - -
			I _{OH} = -16 mA	3.0	2.4	2.8	_	2.4	_	
			$I_{OH} = -24 \text{ mA}$	3.0	2.3	2.68	_	2.3	_	
			$I_{OH} = -32 \text{ mA}$	4.5	3.8	4.2	_	3.8	_	
			100 4	1.8	_	0	0.1	_	0.1	
				2.3	_	0	0.1	_	0.1	
		$I_{OL} = 100 \mu A$	3.0	_	0	0.1	_	0.1		
Low-level	Voi	$V_{IN} = V_{IH}$		4.5	_	0	0.1	_	0.1	
output voltage VOL VI	or V _{IL}	I _{OL} = 8 mA	2.3	_	0.1	0.3	_	0.3	V	
		I _{OL} = 16 mA	3.0	_	0.15	0.4	_	0.4		
		I _{OL} = 24 mA	3.0	_	0.22	0.55	_	0.55		
		I _{OL} = 32 mA	4.5	_	0.22	0.55	_	0.55		
Input leakage current	I _{IN}	V _{IN} = 5.5 V	V _{IN} = 5.5 V or GND		_	_	±1	_	±10	μА
Power off leakage current	loff	V _{IN} or V _{OUT} = 5.5 V		0.0	_	_	1	_	10	μА
Quiescent supply current	Icc	V _{IN} = V _{CC} or GND		5.5	_	_	2	_	20	μА

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AC Characteristics (unless otherwise specified, Input: $t_r = t_f = 3$ ns)

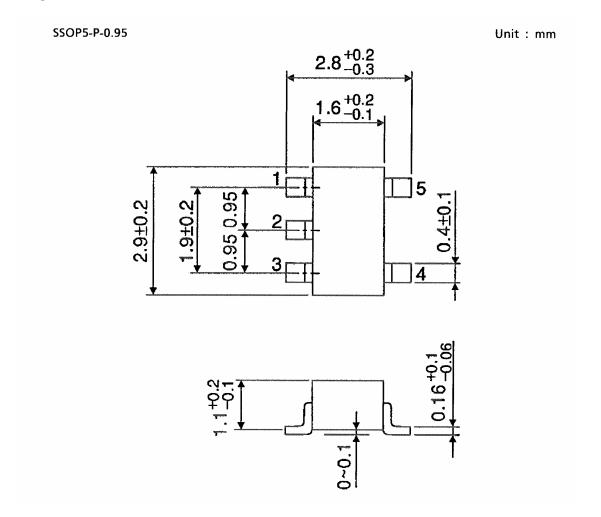
Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C		- Unit	
Gnaracteristics	Syllibol		V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic
		$C_L = 15 \text{ pF},$ $R_L = 1 \text{ M}\Omega$	1.8	2.0	5.7	11.5	2.0	12.0	- ns
			2.5 ± 0.2	0.8	3.8	8.0	0.8	8.5	
Propagation delay time	t _{pLH}		3.3 ± 0.3	0.5	3.0	5.7	0.5	6.0	
			5.0 ± 0.5	0.5	2.4	5.0	0.5	5.4	
		$C_L = 50 \text{ pF},$ $R_L = 500 \Omega$	3.3 ± 0.3	1.2	3.5	6.2	1.5	6.5	
			5.0 ± 0.5	0.8	2.9	5.4	1.0	5.8	
Input capacitance	C _{IN}	_	0~5.5	_	4	_	_	_	pF
Power dissipation capacitance	C _{PD}	(Note 4)	3.3		21				- pF
			5.5	_	24	_	_	_	

Note 4: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

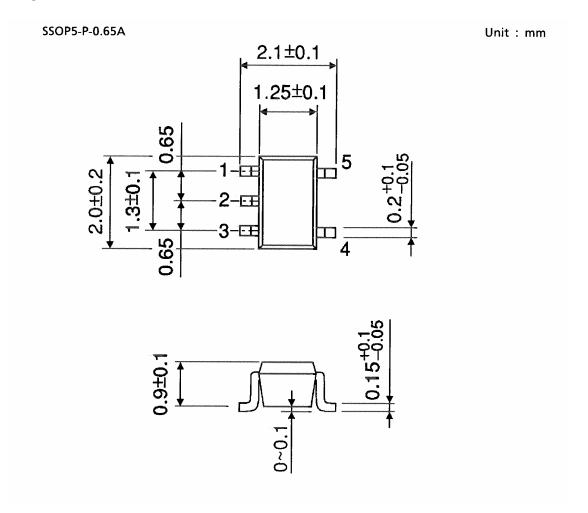
 $I_{CC (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

Package Dimensions



Weight: 0.016 g (typ.)

Package Dimensions



Weight: 0.006 g (typ.)

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20070701-EN GENERAL

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